



### 4-Bit Bidirectional Voltage-Level Translator for Open-Drain and Push-Pull Applications

### **FEATURES**

- No Direction-Control
- Data Rates
   24Mbps (Push-Pull)
   2Mbps (Open-Drain)
- 1.65V to 5.5V on A ports and 2.3V to 5.5V on B Ports (V<sub>CCA</sub>≤V<sub>CCB</sub>)
- V<sub>CC</sub> Isolation: If Either V<sub>CC</sub> is at GND, Both Ports are in the High-Impedance State
- No Power-Supply Sequencing Required: Either V<sub>CCA</sub> or V<sub>CCB</sub> can be Ramped First
- I<sub>OFF</sub>: Supports Partial-Power-Down Mode Operation
- Extended Temperature: -40°C to +85°C

### **APPLICATIONS**

- Handset
- Smartphone
- Tablet
- Desktop PC

#### DESCRIPTION

This 4-bit non-inverting translator is a bidirectional voltage-level translator and can be used to establish digital switching compatibility between mixed-voltage systems. It uses two separate configurable power-supply rails, with the A ports supporting operating voltages from 1.65V to 5.5V while it tracks the  $V_{\rm CCA}$  supply, and the B ports supporting operating voltages from 2.3V to 5.5V while it tracks the  $V_{\rm CCB}$  supply. This allows the support of both lower and higher logic signal levels while providing bidirectional translation capabilities between any of the 1.8V, 2.5V, 3.3V and 5V voltage nodes.

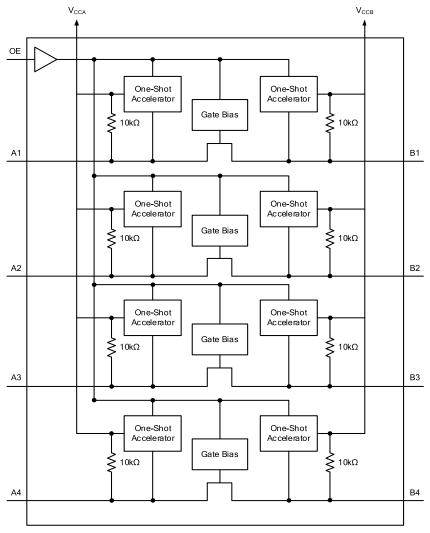
When the output-enable (OE) input is low, all I/Os are placed in the high-impedance state, which significantly reduces the power-supply quiescent current consumption. OE has an internal pull-down current source, as long as  $V_{\text{CCA}}$  is powered.

To ensure the high-impedance state during power up or power down, OE should be tied to GND through a pull-down resistor; the minimum value of the resistor is determined by the current-sourcing capability of the driver.

The RS0104 is available in Green QFN3.5x3.5-14L, QFN2x2-12L, QFN2x1.7-12L and TSSOP-14 packages. It operates over an ambient temperature range of -40°C to +85°C.



### **Functional Block Diagram**



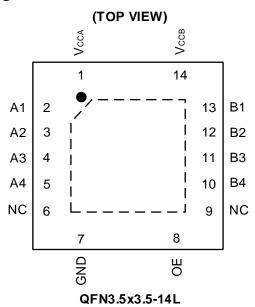
**Block Diagram** 



**Revision History**Note: Page numbers for previous revisions may different from page numbers in the current version.

VERSION	Change Date	Change Item
A.1	2020/11/03	Initial version completed
A.2	2021/01/09	Add Moisture Sensitivity Level information
A.3	2021/04/02	Add QFN2x1.7-12L package
A.4	2021/10/12	1.Change QFN3.5x3.5-14L PACKAGE OPTION 2.Add TAPE AND REEL INFORMATION
A.5	2021/11/01	Change Recommended Operating Conditions in Page 9 @A.4 Version.     Add Typical Characteristics



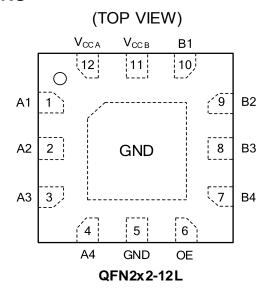


**PIN DESCRIPTION** 

PIN			
QFN3.5x3.5-14L	NAME	TYPE (1)	FUNCTION
1	Vcca	Р	A Port Supply Voltage.1.65V ≤ V <sub>CCA</sub> ≤ 5.5V and V <sub>CCA</sub> ≤ V <sub>CCB</sub> .
2	A1	I/O	Input/output A1. Reference to Vcca.
3	A2	I/O	Input/output A2. Reference to V <sub>CCA</sub> .
4	А3	I/O	Input/output A3. Reference to V <sub>CCA</sub> .
5	A4	I/O	Input/output A4. Reference to Vcca.
6	NC	_	No internal connection.
7	GND	_	Ground.
8	OE	I	Output Enable (Active High). Pull OE low to place all outputs in 3-state mode. Referenced to V <sub>CCA</sub> .
9	NC	_	No internal connection.
10	B4	I/O	Input/output B4. Reference to V <sub>CCB</sub> .
11	В3	I/O	Input/output B3. Reference to V <sub>CCB</sub> .
12	B2	I/O	Input/output B2. Reference to V <sub>CCB</sub> .
13	B1	I/O	Input/output B1. Reference to V <sub>CCB</sub> .
14	V <sub>CCB</sub>	Р	B Ports Supply Voltage.2.3V ≤ V <sub>CCB</sub> ≤ 5.5V.
_	Thermal Pad	_	Exposed pad should be soldered to PCB board and connected to GND or left floating.

<sup>(1)</sup> I=input, O=output, I/O=input and output, P=power



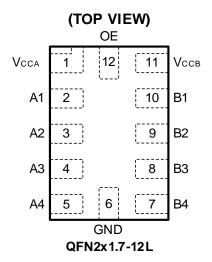


### **PIN DESCRIPTION**

> 1011					
PIN	NAME	TYPE (1)	FUNCTION		
QFN2x2-12L	NAME	TIPE	FONCTION		
1	A1	I/O	Input/output A1. Reference to V <sub>CCA</sub> .		
2	A2	I/O	Input/output A2. Reference to V <sub>CCA</sub> .		
3	A3	I/O	Input/output A3. Reference to V <sub>CCA</sub> .		
4	A4	I/O	Input/output A4. Reference to Vcca.		
5	GND	_	Ground.		
6	OE	I	Output Enable (Active High). Pull OE low to place all outputs in 3-state mode. Referenced to Vcca.		
7	B4	I/O	Input/output B4. Reference to V <sub>CCB</sub> .		
8	В3	I/O	Input/output B3. Reference to V <sub>CCB</sub> .		
9	B2	I/O	Input/output B2. Reference to V <sub>CCB</sub> .		
10	B1	I/O	Input/output B1. Reference to V <sub>CCB</sub> .		
11	V <sub>CCB</sub>	Р	B Ports Supply Voltage.2.3V ≤ V <sub>CCB</sub> ≤ 5.5V.		
12	Vcca	Р	A Port Supply Voltage.1.65V ≤ V <sub>CCA</sub> ≤ 5.5V and V <sub>CCA</sub> ≤ V <sub>CCB</sub> .		
Exposed Pad	GND	-	Exposed pad should be soldered to PCB board and connected to GND or left floating.		

<sup>(2)</sup> I=input, O=output, I/O=input and output, P=power



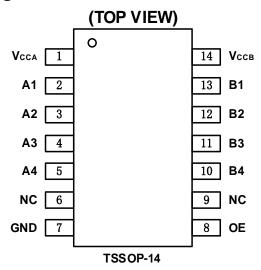


### **PIN DESCRIPTION**

	D = 00 ( 110 )					
PIN	NAME	TYPE (1)	FUNCTION			
QFN2x1.7-12L	NAME	TIPE ( )	FONCTION			
1	$V_{CCA}$	Р	A Port Supply Voltage.1.65V ≤ V <sub>CCA</sub> ≤5.5V and V <sub>CCA</sub> ≤ V <sub>CCB</sub> .			
2	A1	I/O	Input/output A1. Reference to V <sub>CCA</sub> .			
3	A2	I/O	Input/output A2. Reference to V <sub>CCA</sub> .			
4	А3	I/O	Input/output A3. Reference to V <sub>CCA</sub> .			
5	A4	I/O	Input/output A4. Reference to Vcca.			
6	GND	_	Ground.			
7	B4	I/O	Input/output B4. Reference to V <sub>CCB</sub> .			
8	В3	I/O	Input/output B3. Reference to V <sub>CCB</sub> .			
9	B2	I/O	Input/output B2. Reference to V <sub>CCB</sub> .			
10	B1	I/O	Input/output B1. Reference to V <sub>CCB</sub> .			
11	V <sub>CCB</sub>	Р	B Ports Supply Voltage.2.3V ≤ V <sub>CCB</sub> ≤ 5.5V.			
12	OE	I	Output Enable (Active High). Pull OE low to place all outputs in 3-state mode. Referenced to V <sub>CCA</sub> .			

<sup>(1)</sup> I=input, O=output, I/O=input and output, P=power





### PIN DESCRIPTION

FIN DESCRIPTION						
PIN	NAME	TVDE (1)	FUNCTION			
TSSOP-14	NAME	TYPE (1)	FUNCTION			
1	V <sub>CCA</sub>	Р	A Port Supply Voltage.1.65V ≤ V <sub>CCA</sub> ≤ 5.5V and V <sub>CCA</sub> ≤ V <sub>CCB</sub>			
2	A1	I/O	Input/output A1. Reference to V <sub>CCA</sub> .			
3	A2	I/O	Input/output A2. Reference to V <sub>CCA</sub> .			
4	А3	I/O	Input/output A3. Reference to V <sub>CCA</sub> .			
5	A4	I/O	Input/output A4. Reference to V <sub>CCA</sub> .			
6	NC	-	No internal connection.			
7	GND	_	Ground.			
8	OE	1	Output Enable (Active High). Pull OE low to place all outputs in 3-state mode. Referenced to $V_{\text{CCA}}$ .			
9	NC	-	No internal connection.			
10	B4	I/O	Input/output B4. Reference to V <sub>CCB</sub> .			
11	В3	I/O	Input/output B3. Reference to V <sub>CCB</sub> .			
12	B2	I/O	Input/output B2. Reference to V <sub>CCB</sub> .			
13	B1	I/O	Input/output B1. Reference to V <sub>CCB</sub> .			
14	V <sub>ССВ</sub>	Р	B Ports Supply Voltage.2.3V ≤ V <sub>CCB</sub> ≤ 5.5V.			

<sup>(2)</sup> I=input, O=output, I/O=input and output, P=power



### **SPECIFICATIONS**

### **Absolute Maximum Ratings**

Over operating free-air temperature range (unless otherwise noted) (1)

SYMBOL	PARAMETER	MIN	MAX	UNIT	
V <sub>CCA</sub>	Supply Voltage Range	-0.3	6.0	V	
Vccв	Supply Voltage Range	upply Voltage Range			
		A port	-0.3	6.0	
$V_{I}^{(2)}$	Input Voltage Range	B port	-0.3	6.0	.,
	Voltage range applied to any output in the high-	OE	-0.3	6.0	V
Vo <sup>(2)</sup>	Voltage range applied to any output in the high-	A port	-0.3	6.0	.,
VO(=)	impedance or power-off state	B port	-0.3	6.0	V
V (2)(3)	Voltage range applied to any output in the high or low state	A port	-0.3	Vcca+0.3	.,
<b>v</b> O(=)(=)		B port	-0.3	V <sub>CCB</sub> +0.3	V
lıĸ	Input clamp current	Vi<0		-50	mA
Іок	Output clamp current	Vo<0		-25	mA
lo	Continuous output current			±50	mA
	Continuous current through VCCA, VCCB or GND			±100	mA
TJ	Junction Temperature			150	°C
T <sub>stg</sub>	Storage temperature		-65	+150	

<sup>(1)</sup> Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

### **ESD Ratings**

			VALUE	UNIT
Vison	V <sub>(ESD)</sub> Electrostatic discharge	Human-body model (HBM)	±5000	V
V (ESD)		Machine Model (MM)	±400	V

<sup>(2)</sup> The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.

(3) The value of V<sub>CCA</sub> and V<sub>CCB</sub> are provided in the recommended operating conditions table.



### **Recommended Operating Conditions**

V<sub>CCI</sub> is the supply voltage associated with the input port. V<sub>CCO</sub> is the supply voltage associated with the output port.

PARAMETER		CONDITIONS	MIN	TYP	MAX	UNIT
Supply voltage (1)	Vcca	Vcca			5.5	V
Supply voltage (*)	V <sub>CCB</sub>		2.3		5.5	\ \
	A port I/Os	V <sub>CCA</sub> = 1.65 V to 1.95 V V <sub>CCB</sub> = 2.3 V to 5.5 V	V <sub>CCI</sub> – 0.2		Vccı	V
High-level input voltage	A-port i/Os	V <sub>CCA</sub> = 2.3 V to 5.5 V V <sub>CCB</sub> = 2.3 V to 5.5 V	Vccı - 0.4		Vccı	V
(V <sub>IH</sub> )	B-port I/Os	V <sub>CCA</sub> = 1.65 V to 5.5 V V <sub>CCB</sub> = 2.3 V to 5.5 V	V <sub>CCI</sub> - 0.4		V <sub>CCI</sub>	V
	OE input	V <sub>CCA</sub> = 1.65 V to 5.5 V V <sub>CCB</sub> = 2.3 V to 5.5 V	V <sub>CCA</sub> × 0.8		5.5	V
	A-port I/Os	V <sub>CCA</sub> = 1.65 V to 5.5 V V <sub>CCB</sub> = 2.3 V to 5.5 V	0		0.15	V
(Viн)  Low-level input voltage (Vi∟)  Input transition rise or fall	B-port I/Os	$V_{CCA} = 1.65 \text{ V to } 5.5 \text{ V}$ $V_{CCB} = 2.3 \text{ V to } 5.5 \text{ V}$	0		0.15	V
. ,	OE input	$V_{CCA} = 1.65 \text{ V to } 5.5 \text{ V}$ $V_{CCB} = 2.3 \text{ V to } 5.5 \text{ V}$	0		V <sub>CCA</sub> <b>×</b> 0.25	٧
	A-port I/Os    VCCB = 2.3 V to 5.5 V   VCCI - 0.			10	ns/V	
Input transition rise or fall rate( $\Delta t/\Delta v$ )		·			10	ns/V
		Control input			10	ns/V
T <sub>A</sub> Operating free-air temp	perature		-40		85	°C

<sup>(1)</sup> V<sub>CCA</sub> must be less than or equal to V<sub>CCB</sub>.
(2) The maximum V<sub>IL</sub> value is provided to ensure that a valid V<sub>OL</sub> is maintained. The V<sub>OL</sub> value is V<sub>IL</sub> plus the voltage drop across the pass gate transistor.



### **PACKAGE/ORDERING INFORMATION**

PRODUCT	ORDERING NUMBER	TEMPERATURE RANGE	PACKAGE LEAD	PACKAGE MARKING (1)	MSL <sup>(2)</sup>	PACKAGE OPTION
	RS0104YTQF14	-40°C ~+85°C	QFN3.5x3.5- 14L	RS0104	MSL3	Tape and Reel,5000
RS0104	RS0104YTQE12	-40°C ~+85°C	QFN2x2-12L	0104	MSL3	Tape and Reel,3000
N30104	RS0104YUTQH12	-40°C ~+85°C	QFN2x1.7-12L	0104	MSL3	Tape and Reel,4000
	RS0104YQ	-40°C ~+85°C	TSSOP-14	RS0104	MSL3	Tape and Reel,4000

#### NOTE:

<sup>(1)</sup> There may be additional marking, which relates to the lot trace code information(data code and vendor code), the logo or the environmental category on the device.

<sup>(2)</sup> MSL, The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications.



### **Electrical Characteristics**

P/	ARAMETER	CONDITIONS	Vcca	V <sub>ССВ</sub>	TEMP	MIN	TYP	MAX	UNITS
Vона	Port A output high voltage	$I_{OH} = -20 \mu A$ $V_{IB} \ge V_{CCB} - 0.4V$	1.65V to 5.5V	2.3V to 5.5V	Full	V <sub>CCA</sub> × 0.7		5.5	
Vola	Port A output low voltage	$I_{OL} = 1mA$ $V_{IB} \le 0.15 \text{ V}$	1.65V to 5.5V	2.3V to 5.5V	Full			0.3	V
V <sub>OHB</sub>	Port B output high voltage	$I_{OH} = -20 \mu A$ $V_{IA} \ge V_{CCA} - 0.4 V$	1.65V to 5.5V	2.3V to 5.5V	Full	V <sub>ССВ</sub> × 0.7		V	
Volb	Port B output low voltage	$I_{OL} = 1mA$ $V_{IA} \leq 0.15 \text{ V}$	1.65V to 5.5V	2.3V to 5.5V	Full			0.3	
lı	Input leakage	OE	1.65V to 5.5V	2.3V to 5.5V	+25° <b>C</b>			±1	μA
"	current	OL .	1.03 V 10 3.3 V	2.5 10 5.5 1	Full			±1.5	μΛ
		A Ports	0V	0V to 5.5V	+25° <b>C</b>			±0.5	μA
1	Partial power	A FOILS	OV	0 0 0 5.5 0	Full			±1	μΑ
l <sub>off</sub>	down current	D. Dorto	0)/ to F F)/	0V	+25° <b>C</b>			±0.5	
		B Ports	0V to 5.5V		Full			±1	μA
	High- impedance	A or B port	or B port E=0V 1.65V to 5.5V	2.3V to 5.5V	+25° <b>C</b>			±0.5	
l <sub>OZ</sub>	State output current	OE=0V			Full			±1	μA
	I <sub>CCA</sub> V <sub>CCA</sub> supply current	$V_1 = V_0 = \text{open}$ $I_0 = 0$	1.65V to V <sub>CCB</sub>	2.3V to 5.5V	Full			1.0	
$I_{\text{CCA}}$			$V_1 = V_0 = open$ $I_0 = 0$	5.5V	0V	Full			1.0
			0V	5.5V	Full			-1	r
			1.65V to V <sub>CCB</sub>	2.3V to 5.5V	Full			10	
$I_{CCB}$	V <sub>CCB</sub> supply current	$V_1 = V_0 = open$ $I_0 = 0$	5.5V	0V	Full			-1	μΑ
	04.10.11		0V	5.5V	Full			1	
Icca + Iccb	Combined supply current	V <sub>I</sub> = V <sub>CCI</sub> or GND I <sub>O</sub> = 0	1.65V to V <sub>CCB</sub>	2.3V to 5.5V	Full			15	μΑ
Iccza	V <sub>CCA</sub> supply current	V <sub>I</sub> = V <sub>CCI</sub> or 0V I <sub>O</sub> = 0, OE=0V	1.65V to V <sub>CCB</sub>	2.3V to 5.5V	Full			1	μΑ
I <sub>CCZB</sub>	V <sub>CCB</sub> supply current	$V_1 = V_{CCI}$ or $0V$ $I_0 = 0$ , $OE=0V$	2.3V to 5.5V	2.3V to 5.5V	Full			1	μA
Сі	Input capacitance	OE	3.3V	3.3V	+25° <b>C</b>		2.5		pF
	Input-to- output	A port	3.3V	3.3V	+25° <b>C</b>		5		_
Сю	internal capacitance	B port	3.3V	3.3V	+25° <b>C</b>		5		pF

<sup>(1)</sup>  $V_{\text{CCI}}$  is the  $V_{\text{CC}}$  associated with the input port. (2)  $V_{\text{CCO}}$  is the  $V_{\text{CC}}$  associated with the output port. (3)  $V_{\text{CCA}}$  must be less than or equal to  $V_{\text{CCB}}$ .



### **Timing Requirements**

### Vcca=1.8V±0.15 V

		V <sub>CCB</sub> =2.5V ±0.2V	V <sub>CCB</sub> =3.3V ±0.2V	V <sub>CCB</sub> =5V ±0.2V	UNIT
		TYP	TYP	TYP	UNIT
Data rate	Push-pull driving	21	22	24	Mhna
	Open-drain driving	2	2	2	Mbps
Pulse duration(t <sub>w</sub> )	Push-pull driving (data inputs)	47	45	41	20
	Open-drain driving (data inputs)	500	500	500	ns

### Vcca=2.5V±0.15 V

		V <sub>CCB</sub> =2.5V ±0.2V	V <sub>CCB</sub> =3.3V ±0.2V	V <sub>CCB</sub> =5V ±0.2V	UNIT
		TYP	TYP	TYP	UNIT
	Push-pull driving	20	22	24	Mhna
Data rate	Open-drain driving	2	2	2	Mbps
Pulse duration(t <sub>w</sub> )	Push-pull driving (data inputs)	50	45	41	20
	Open-drain driving (data inputs)	500	500	500	ns

### V<sub>CCA</sub>=3.3V±0.15 V

		V <sub>CCB</sub> =3.3V ±0.2V	V <sub>CCB</sub> =5V ±0.2V	LINIT
		TYP	TYP	UNIT
Data rata	Push-pull driving	23	24	Mhna
Data rate	Open-drain driving	2	2	Mbps
Pulse	Push-pull driving (data inputs)	43	41	20
duration(tw)	Open-drain driving (data inputs)	500	500	ns

### V<sub>CCA</sub>=5V±0.15 V

		V <sub>CCB</sub> =5V ±0.2V	UNIT
		ТҮР	UNIT
Data rata	Push-pull driving	24	Mhna
Data rate	Open-drain driving	2	Mbps
Pulse	Push-pull driving (data inputs)	41	20
duration(t <sub>w</sub> )	Open-drain driving (data inputs)	500	ns



### Switching Characteristics: $V_{CCA}=1.8V \pm 0.15V$

DA	RAMETER	CONDITIONS		V <sub>CCB</sub> =2.5V±0.2V	V <sub>CCB</sub> =3.3V±0.2V	V <sub>CCB</sub> =5V±0.2V	UNITS	
PA	KAWEIEK		ONDITIONS	TYP	TYP	TYP	UNITS	
	Propagation		Push-pull driving	2.5	3.1	4.5		
t <sub>PHL</sub>	delay time high-to-low output	A-to-B	Open-drain driving	26.1	26.4	26.6	ns	
	Propagation		Push-pull driving	4.2	3.7	3.6		
t <sub>PLH</sub>	delay time low-to-high output	A-to-B	Open-drain driving	221	183	143	ns	
	Propagation		Push-pull driving	2.1	2.0	2.2		
t <sub>PHL</sub>	delay time high-to-low output	B-to-A	Open-drain driving	26.1	26.1	26.2	ns	
	Propagation		Push-pull driving	1.8	1.6	1.5		
t <sub>PLH</sub>	delay time low-to-high output		Open-drain driving	173	89	66	ns	
t <sub>en</sub>	Enable time	OE-to-A	or B	25	21	19	ns	
t <sub>dis</sub>	Disable time	OE-to-A	or B	1250	1250	1250	ns	
4.	Input rise	A port rise	Push-pull driving	6.9	6.1	5.6	no	
t <sub>rA</sub>	time	time	Open-drain driving	118	39	13	ns	
	Input rise	B port	Push-pull driving	5.8	4.8	4.1		
<b>t</b> rB	time	rise time	Open-drain driving	166	127	75	ns	
4	Input fall	A port	Push-pull driving	3.0	2.8	2.7	no	
<b>t</b> fA	time	fall time	Open-drain driving	1.9	1.7	1.6	ns	
t	Input fall	B port	Push-pull driving	4.8	6.2	8.4	no	
<b>t</b> fB	time	fall time	Open-drain driving	2.3	2.4	2.8	ns	
tsk(o)	Skew(time), output	Channel-	to-Channel Skew	0.5	0.5	0.5	ns	
Maxim	num data rate	Push-pul	driving	21	22	24	Mhns	
ινιαλί	iuiii uala lale	Open-dra	in driving	2	2	2	Mbps	



### Switching Characteristics: $V_{CCA}=2.5V \pm 0.15V$

DA	DAMETED		ONDITIONS	V <sub>CCB</sub> =2.5V±0.2V	V <sub>CCB</sub> =3.3V±0.2V	V <sub>CCB</sub> =5V±0.2V	LINUTO	
PA	RAMETER	CONDITIONS		TYP	TYP	TYP	UNITS	
tphL	Propagation delay time	A-to-B	Push-pull driving	2.8	3.4	5.0	ns	
THE	high-to-low output	77 10 15	Open-drain driving	26.3	26.5	26.6	113	
<b>t</b> pLH	Propagation delay time	A-to-B	Push-pull driving	2.7	2.5	2.4	ns	
IPLH .	low-to-high output	A-10-D	Open-drain driving	198	169	131	113	
tou	Propagation delay time	B-to-A	Push-pull driving	2.5	2.4	2.5	ns	
t <sub>PHL</sub>	high-to-low output	D-10-A	Open-drain driving	26.4	26.5	26.6	113	
t <sub>PLH</sub>	Propagation delay time	B-to-A	Push-pull driving	2.1	2.0	1.9	ns	
IPLH	- low-to-high   b-to- output		Open-drain driving	196	138	63	113	
ten	Enable time	OE-to-A or B		24	20	17	ns	
t <sub>dis</sub>	Disable time	OE-to-A	or B	1250	1250	1250	ns	
	Input rise	A port	Push-pull driving	3.4	2.9	2.7		
t <sub>rA</sub>	time	rise time	Open-drain driving	156	92	13	ns	
	Input rise	B port	Push-pull driving	4.7	3.5	2.7		
<b>t</b> rB	time	rise time	Open-drain driving	160	124	81	ns	
	Input fall	A port	Push-pull driving	5.1	5.2	5.0		
t <sub>fA</sub>	time	fall time	Open-drain driving	2.1	2.0	1.8	ns	
	Input fall E	B port	Push-pull driving	5.0	6.4	8.7		
t <sub>fB</sub>	B time fall tir		Open-drain driving	2.0	2.2	2.8	ns	
t <sub>SK(O)</sub>	Skew(time), output	Channel-to-channel skew		0.5	0.5	0.5	ns	
Mavim	num data rate	Push-pul	driving	20	22	24	Mbps	
ividXiff	iuiii uala fale	Open-dra	in driving	2	2	2	Mbps	



### Switching Characteristics: $V_{\text{CCA}}$ =3.3V ± 0.3V

PARAMETER		CONDITIONS		V <sub>CCB</sub> =3.3V±0.2V	V <sub>CCB</sub> =5V±0.2V	UNITS	
Ρ/	ARAMETER	,	CONDITIONS	TYP	TYP	UNITS	
tphL	Propagation delay time	A-to-B	Push-pull driving	3.6	5.1	ns	
TPHE	high-to-low output	7.10 B	Open-drain driving	26.4	26.6	113	
tplH	Propagation delay time	A-to-B	Push-pull driving	2.3	2.1	- ns	
TPLH	low-to-high output	A-10-D	Open-drain driving	155	109	113	
t <sub>PHL</sub>	Propagation delay time	B-to-A	Push-pull driving	3.1	3.3	ns	
TPHL	high-to-low output	D to A	Open-drain driving	26.5	26.7	113	
<b>t</b> pLH	Propagation delay time	B-to-A	Push-pull driving	1.9	1.8	ns	
tPLH .	low-to-high output	Open-drain driving	158	87	113		
t <sub>en</sub>	Enable time	OE-to-A or B	OE-to-A or B		15	ns	
t <sub>dis</sub>	Disable time	OE-to-A or B		1250	1250	ns	
<b>+</b> .	Input rise time	A port rise	Push-pull driving	2.3	2.1	ne	
t <sub>rA</sub>	input rise time	time	Open-drain driving	117	48	ns	
+ -	Input rise time	B port rise	Push-pull driving	3.0	2.4	200	
<b>t</b> rB	input rise time	time	Open-drain driving	117	75	ns	
ŧ.,	Input fall time	A port fall	Push-pull driving	8.0	7.6	ns	
t <sub>fA</sub>	input iaii tiine	time	Open-drain driving	2.2	2.1	115	
+	Input fall time	B port fall	Push-pull driving	8.2	10.8	200	
<b>t</b> fB	input fall tilfle	time	Open-drain driving	2.1	2.4	ns	
tsk(O)	Skew(time), output	Channel-to-ch	Channel-to-channel skew		0.5	ns	
Movim	um data rata	Push-pull driv	ing	23	24	Mhns	
iviaxim	um data rate	Open-drain driving		2	2	Mbps	

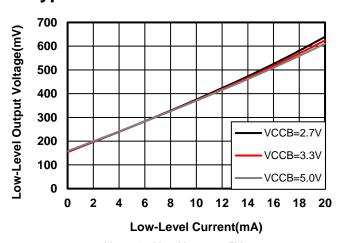


## Switching Characteristics: $V_{CCA}$ =5.0V ± 0.35V

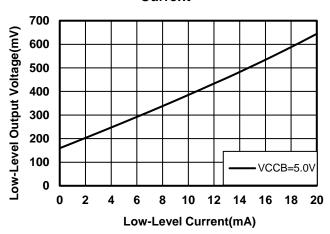
PARAMETER		CONDITIONS		V <sub>CCB</sub> =5V±0.2V	UNITS	
r	'ARAIVIE I ER		ONDITIONS	TYP	UNITS	
tphL	Propagation delay time	A-to-B	Push-pull driving	5.6	ns	
	high-to-low output		Open-drain driving	26.8		
t <sub>PLH</sub>	Propagation delay time	A-to-B	Push-pull driving	2.0	ns	
IPLH .	low-to-high output	A-10-D	Open-drain driving	155	113	
t <sub>PHL</sub>	Propagation delay time	B-to-A	Push-pull driving	5.8	ns	
PHL	high-to-low output	B-10-A	Open-drain driving	27.5	113	
<b>t</b> PLH	Propagation delay time	B-to-A	Push-pull driving	1.8	ns	
IPLH	low-to-high output	B-10-A	Open-drain driving	160	115	
t <sub>en</sub>	Enable time	OE-to-A or B		17	ns	
t <sub>dis</sub>	Disable time	OE-to-A or B		1250	ns	
$t_{rA}$	Input rise time	A port rise time	Push-pull driving	1.9	ns	
чA	input rise time	A port rise time	Open-drain driving	105	113	
t <sub>rB</sub>	Input rise time	B port rise time	Push-pull driving	2.3	ns	
цВ	input noe time	b port rise time	Open-drain driving	95	113	
$\mathbf{t}_{fA}$	Input fall time	A port fall time	Push-pull driving	9.0	ns	
ча	input fail time	A port rail time	Open-drain driving	2.6	113	
$t_fB$	Input fall time	B port fall time	Push-pull driving	8.9	ns	
LID.	input fail time	B port rail time	Open-drain driving	2.5	113	
tsk(o)	Skew(time), output	Channel-to-chanr	nel skew	0.5	ns	
lovimum	o data rata	Push-pull driving		24	Mba	
Maximum data rate		Open-drain driving		2	Mbps	



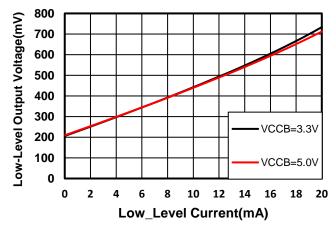
### **Typical Characteristics**



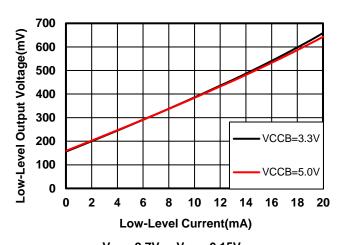
V<sub>CCA</sub>=1.8V V<sub>IL(A)</sub>=0.15V Figure1: Low-Level Output Voltage vs Low-Level Current



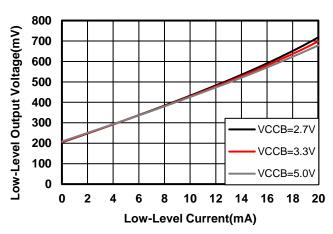
V<sub>CCA</sub>=3.3V V<sub>IL(A)</sub>=0.15V Figure3: Low-Level Output Voltage vs Low-Level Current



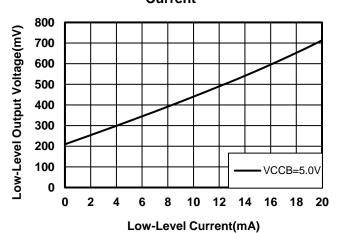
V<sub>CCA</sub>=2.7V V<sub>IL(A)</sub>=0.20V Figure5: Low-Level Output Voltage vs Low-Level Current



V<sub>CCA</sub>=2.7V V<sub>IL(A)</sub>=0.15V Figure2: Low-Level Output Voltage vs Low-Level Current



V<sub>CCA</sub>=1.8V V<sub>IL(A)</sub>=0.20V Figure4: Low-Level Output Voltage vs Low-Level Current

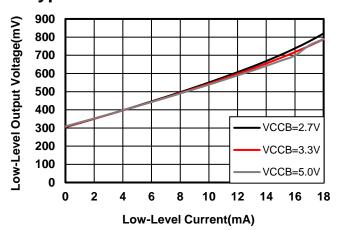


VCCA=3.3V VIL(A)=0.20V

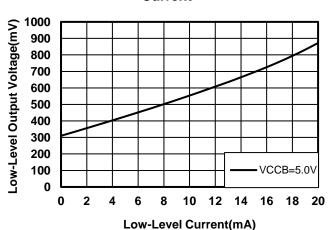
Figure6: Low-Level Output Voltage vs Low-Level
Current



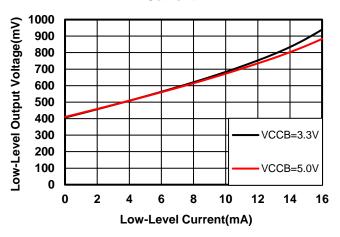
### **Typical Characteristics**



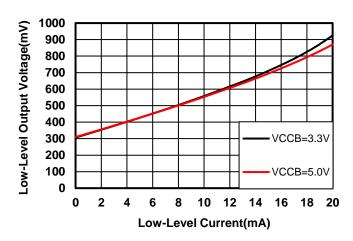
V<sub>CCA</sub>=1.8V V<sub>IL(A)</sub>=0.30V Figure7: Low-Level Output Voltage vs Low-Level Current



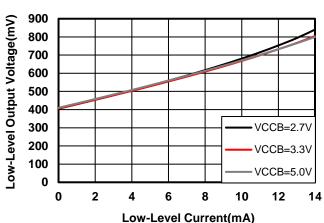
V<sub>CCA</sub>=3.3V V<sub>IL(A)</sub>=0.30V Figure9: Low-Level Output Voltage vs Low-Level Current



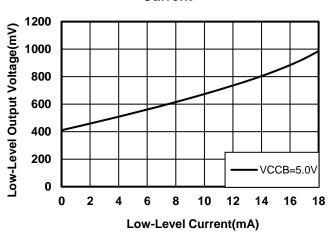
V<sub>CCA</sub>=2.7V V<sub>IL(A)</sub>=0.40V Figure11: Low-Level Output Voltage vs Low-Level Current



V<sub>CCA</sub>=2.7V V<sub>IL(A)</sub>=0.30V Figure8: Low-Level Output Voltage vs Low-Level Current



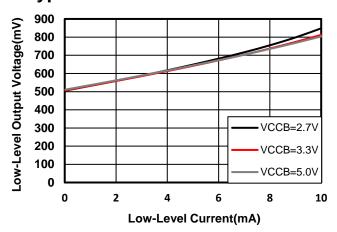
V<sub>CCA</sub>=1.8V V<sub>IL(A)</sub>=0.40V Figure10: Low-Level Output Voltage vs Low-Level Current



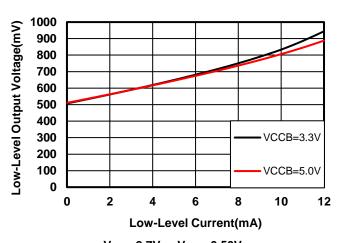
V<sub>CCA</sub>=3.3V V<sub>IL(A)</sub>=0.40V Figure12: Low-Level Output Voltage vs Low-Level Current



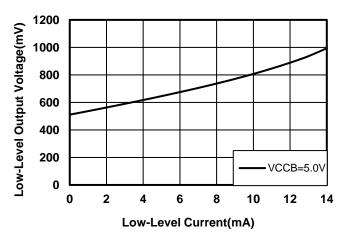
### **Typical Characteristics**



V<sub>CCA</sub>=1.8V V<sub>IL(A)</sub>=0.50V Figure13: Low-Level Output Voltage vs Low-Level Current



V<sub>CCA</sub>=2.7V V<sub>IL(A)</sub>=0.50V Figure14: Low-Level Output Voltage vs Low-Level Current



V<sub>CCA</sub>=3.3V V<sub>IL(A)</sub>=0.50V Figure15: Low-level Output Voltage vs Low-Level Current



### **Parameter Measurement Information**

Unless otherwise noted, all input pulses are supplied by generators having the following characteristics:

- PRR 10 MHz
- $Z_0 = 50 \Omega$
- $dv/dt \ge 1 V/ns$

Note: All input pulses are measured one at a time, with one transition per measurement.

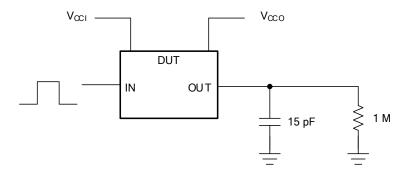


Figure 16. Data Rate, Pulse Duration, Propagation Delay, Output Rise And Fall Time Measurement Using A Push-Pull Driver

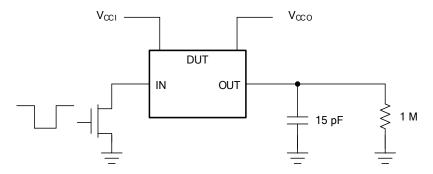


Figure 17. Data Rate, Pulse Duration, Propagation Delay, Output Rise And Fall Time Measurement Using an Open-Drain Driver

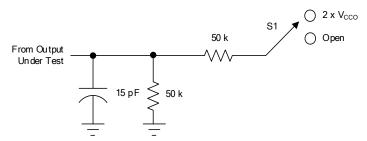


Figure 18. Load Circuit for Enable/Disable Time Measurement

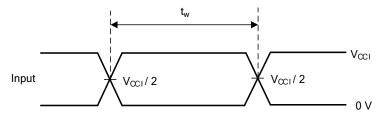
Table 1. Switch Configuration for Enable/Disable Timing

TEST	S1
t <sub>PZL</sub> <sup>(1)</sup> , t <sub>PLZ</sub> <sup>(2)</sup>	2 × V <sub>CCO</sub>
t <sub>PHZL</sub> <sup>(1)</sup> , t <sub>PZH</sub> <sup>(2)</sup>	Open

<sup>(1)</sup>  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .

<sup>(2)</sup>  $t_{\text{PLZ}}$  and  $t_{\text{PHZ}}$  are the same as  $t_{\text{dis}}$ .





(1) All input pulses are measured one at a time, with one transition per measurement.

Figure 19. Voltage Waveforms Pulse Duration

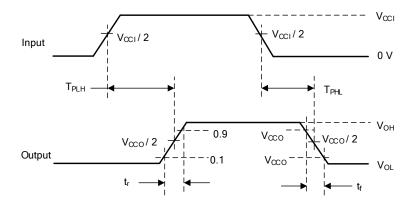


Figure 20. Voltage Waveforms Propagation Delay Times

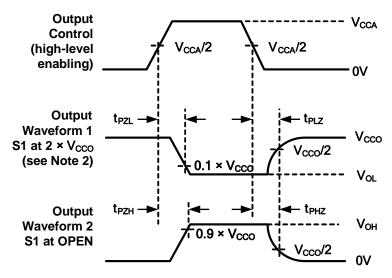


Figure 21. Voltage Waveforms Enable and Disable



### **Feature Description**

#### **Overview**

The RS0104 device is a directionless voltage-level translator specifically designed for translating logic voltage levels. The A port is able to accept I/O voltages ranging from 1.65 V to 5.5 V, while the B port can accept I/O voltages from 2.3 V to 5.5 V. The device is a pass-gate architecture with edge-rate accelerators (one-shots) to improve the overall data rate. 10-k $\Omega$  pullup resistors, commonly used in open-drain applications, have been conveniently integrated so that an external resistor is not needed. While this device is designed for open-drain applications, the device can also translate push-pull CMOS logic outputs.

#### **Architecture**

The RS0104 architecture (see Figure 22) is an auto-direction-sensing based translator that does not require a direction-control signal to control the direction of data flow from A to B or from B to A. These two bidirectional channels independently determine the direction of data flow without a direction-control signal. Each I/O pin can be automatically reconfigured as either an input or an output, which is how this auto-direction feature is realized.

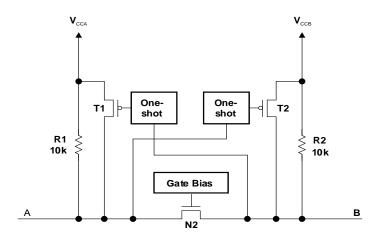


Figure 22. Architecture of a RS0104 Cell

The RS0104 employs two key circuits to enable this voltage translation:

- 1) An N-channel pass-gate transistor topology that ties the A-port to the B-port
- 2) Output one-shot (O.S.) edge-rate accelerator circuitry to detect and accelerate rising edges on the A or B Ports.

#### **Input Driver Requirements**

The continuous dc-current "sinking" capability is determined by the external system-level open-drain (or push-pull) drivers that are interfaced to the RS0104 I/O pins. Since the high bandwidth of these bidirectional I/O circuits is used to facilitate this fast change from an input to an output and an output to an input, they have a modest dc-current "sourcing" capability of hundreds of micro-Amps, as determined by the internal  $10-k\Omega$  pullup resistors.

The fall time ( $t_{fA}$ ,  $t_{fB}$ ) of a signal depends on the edge-rate and output impedance of the external device driving RS0104 data I/Os, as well as the capacitive loading on the data lines.

Similarly, the  $t_{PHL}$  and max data rates also depend on the output impedance of the external driver. The values for  $t_{fA}$ ,  $t_{fB}$ ,  $t_{PHL}$  and maximum data rates in the data sheet assume that the output impedance of the external driver is less than 50  $\Omega$ .



### **Feature Description**

### **Output Load Considerations**

We recommend careful PCB layout practices with short PCB trace lengths to avoid excessive capacitive loading and to ensure that proper O.S. triggering takes place. PCB signal trace-lengths should be kept short enough such that the round-trip delay of any reflection is less than the one-shot duration. This improves signal integrity by ensuring that any reflection sees a low impedance at the driver. The O.S. circuits have been designed to stay on for approximately 30 ns. The maximum capacitance of the lumped load that can be driven also depends directly on the one-shot duration. With very heavy capacitive loads, the one-shot can time-out before the signal is driven fully to the positive rail. The O.S. duration has been set to best optimize trade-offs between dynamic ICC, load driving capability, and maximum bit-rate considerations. Both PCB trace length and connectors add to the capacitance that the RS0104 device output sees, so it is recommended that this lumped-load capacitance be considered to avoid O.S. retriggering, bus contention, output signal oscillations, or other adverse system-level affects.

#### **Enable and Disable**

The RS0104 device has an OE input that is used to disable the device by setting OE low, which places all I/Os in the Hi-Z state. The disable time (tdis) indicates the delay between the time when OE goes low and when the outputs are disabled (Hi-Z). The enable time (ten) indicates the amount of time the user must allow for the one-shot circuitry to become operational after OE is taken high.

#### Pullup or Pulldown Resistors on I/O Lines

Each A-port I/O has an internal  $10-k\Omega$  pullup resistor to  $V_{CCA}$ , and each B-port I/O has an internal  $10-k\Omega$  pullup resistor to  $V_{CCB}$ . If a smaller value of pullup resistor is required, an external resistor must be added from the I/O to  $V_{CCA}$  or  $V_{CCB}$  (in parallel with the internal  $10-k\Omega$  resistors). Adding lower value pull-up resistors will affect  $V_{OL}$  levels, however. The internal pull-ups of the RS0104 are disabled when the OE pin is low.



### **Application Information**

The RS0104 device can be used to bridge the digital-switching compatibility gap between two voltage nodes to successfully interface logic threshold levels found in electronic systems. It should be used in a point-to-point topology for interfacing devices or systems operating at different interface voltages with one another. Its primary target application use is for interfacing with open-drain drivers on the data I/Os such as I<sub>2</sub>C or 1-wire, where the data is bidirectional and no control signal is available. The device can also be used in applications where a push-pull driver is connected to the data I/Os, but the RS0104 might be a better option for such push-pull applications.

#### **Typical Application**

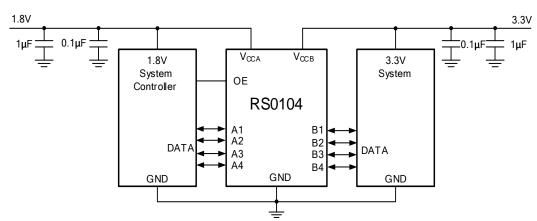
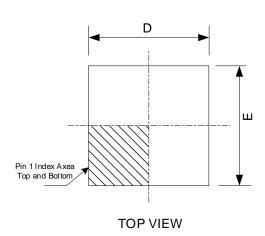
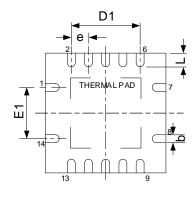


Figure 23. Typical Application Circuit

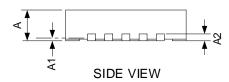


# PACKAGE OUTLINE DIMENSIONS QFN3.5x3.5-14L





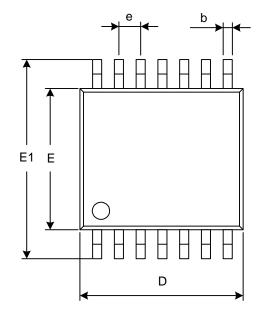


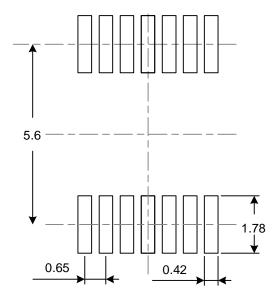


Cumbal	Dimensions I	In Millimeters	Dimension	s In Inches	
Symbol	Min	Max	Min	Max	
А	0.800	1.000	0.031	0.039	
A1	0.000	0.050	0.000	0.002	
A2	0.200	) REF	0.008 REF		
b	0.180	0.300	0.007	0.012	
D	3.350	3.650	0.132	0.144	
D1	2.000	) TYP	0.079	) TYP	
E	3.350	3.650	0.007	0.012	
E1	1.500 TYP		0.059 TYP		
е	0.500	) TYP	0.020 TYP		
L	0.300	0.500	0.012 0.020		



### TSSOP-14





RECOMMENDED LAND PATTERN (Unit: mm)

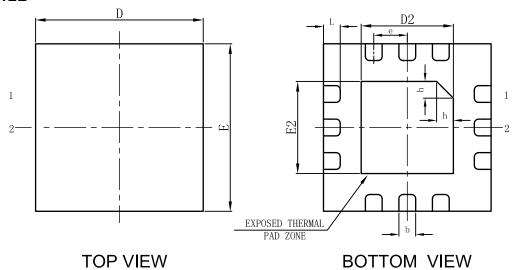


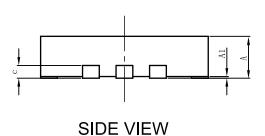


County of	Dimensions	In Millimeters	Dimensions In Inches		
Symbol	Min	Max	Min	Max	
А		1.200		0.047	
A1	0.050	0.150	0.002	0.006	
A2	0.800	1.050	0.031	0.041	
b	0.190	0.300	0.007	0.012	
С	0.090	0.200	0.004	0.008	
D	4.860	5.100	0.191	0.201	
E	4.300	4.500	0.169	0.177	
E1	6.250	6.550	0.246	0.258	
е	0.650	0.650(BSC)		(BSC)	
L	0.500	0.700	0.020 0.028		
Н	0.250	(TYP)	0.010(TYP)		
θ	1°	7°	1°	7°	



### QFN2x2-12L

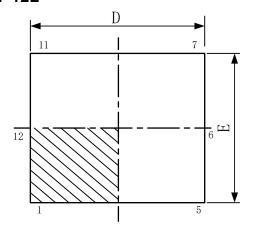


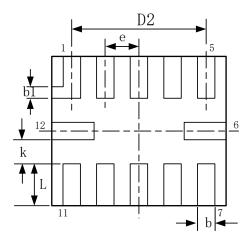


Compleal	Dimensions I	n Millimeters	Dimensions In Inches		
Symbol	Min	Max	Min	Max	
А	0.450	0.550	0.018	0.022	
A1	0.000	0.050	0.000	0.002	
С	0.100	0.200	0.004	0.008	
b	0.150	0.250	0.006	0.010	
D	1.900	2.100	0.075	0.083	
E	1.900	2.100	0.075	0.083	
D2	1.000	1.200	0.039	0.057	
E2	1.000	1.200	0.039	0.057	
е	0.400	BSC	0.016 BSC		
h	0.150	0.250	0.006	0.010	
L	0.150	0.250	0.006 0.010		



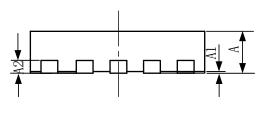
### QFN2x1.7-12L





**TOP VIEW** 

**BOTTOM VIEW** 



SIDE VIEW

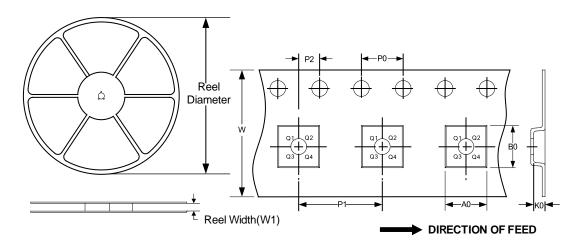
Compleal	Dimensions I	n Millimeters	Dimensions In Inches		
Symbol	Min Max		Min	Max	
А	0.450	0.550	0.018	0.022	
A1	0.000	0.050	0.000	0.002	
A2	0.152	REF	0.006	REF	
D	1.900	2.100	0.075	0.083	
E	1.600	1.800	0.063	0.071	
D2	1.500	1.700	0.059	0.067	
b	0.150	0.250	0.006	0.010	
b1	0.150	REF	0.006	REF	
k	0.250	REF	0.010 REF		
е	0.400	BSC	0.016 BSC		
L	0.400	0.600	0.016	0.024	



### TAPE AND REEL INFORMATION

### **REEL DIMENSIONS**

### **TAPE DIMENSION**



NOTE: The picture is only for reference. Please make the object as the standard.

### **KEY PARAMETER LIST OF TAPE AND REEL**

Package Type	Reel Diameter	Reel Width W1(mm)	A0 (mm)	B0 (mm)	K0 (mm)	P0 (mm)	P1 (mm)	P2 (mm)	W (mm)	Pin1 Quadrant
QFN3.5x3.5-14L	13"	12.4	4.0	4.0	1.10	4.0	8.0	2.0	12.0	Q1
TSSOP-14	13"	12.4	6.95	5.60	1.20	4.0	8.0	2.0	12.0	Q1
QFN1.7x2-12L	7"	9.0	1.90	2.30	0.75	4.0	4.0	2.0	8.0	Q1
QFN2x2-12L	7"	9.0	2.13	2.13	0.88	4.0	4.0	2.0	8.0	Q1